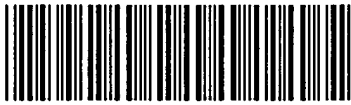


Search Notes

Application/Control No.

10/606,696

Examiner

Truc T. T. Nguyen

Applicant(s)/Patent under
Reexamination

HORIKOSHI ET AL.

Art Unit

2833

SEARCHED

Class	Subclass	Date	Examiner
439	79-80 246-248	5/3/2005	TN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
same as searched above		5/3/2005	tn

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR